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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/669,083	09/23/2003	Eric Picollet	STMI07-01185	1866
23990 7.	590 12/13/2004		EXAM	INER
DOCKET CLERK			DOUGHERTY, ANTHONY T	
P.O. DRAWER 800889 DALLAS, TX 75380			ART UNIT	PAPER NUMBER
21.22.13, 111			2863	-

DATE MAILED: 12/13/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

	Δr	pplication No.	Applicant(s)			
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Office Action Summary		0/669,083 	PICOLLET ET AL.			
omee Action cumma		aminer	Art Unit			
The MAU INC DATE of this con		thony T. Dougherty	2863			
The MAILING DATE of this cor Period for Reply	птитсаноп аррват	s on the cover sheet with the t	orrespondence address			
A SHORTENED STATUTORY PERI THE MAILING DATE OF THIS COM - Extensions of time may be available under the pre after SIX (6) MONTHS from the mailing date of the - If the period for reply specified above, the maxi Failure to reply within the set or extended period of Any reply received by the Office later than three nearned patent term adjustment. See 37 CFR 1.70	MUNICATION. ovisions of 37 CFR 1.136(a). is communication. thirty (30) days, a reply withi mum statutory period will ap or reply will, by statute, caus nonths after the mailing date	In no event, however, may a reply be tinn the statutory minimum of thirty (30) day ply and will expire SIX (6) MONTHS from the application to become ABANDONE	nely filed /s will be considered timely. In the mailing date of this communication. ED (35 U.S.C. § 133).			
Status						
1) Responsive to communication	(s) filed on 19 March	n 2004.				
2a)☐ This action is FINAL .						
·	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.					
Disposition of Claims						
4) ⊠ Claim(s) 1-16 is/are pending in 4a) Of the above claim(s) 5) ⊠ Claim(s) 1-16 is/are allowed. 6) □ Claim(s) is/are rejected. 7) □ Claim(s) is/are objected. 8) □ Claim(s) are subject to	_ is/are withdrawn for					
Application Papers						
9) The specification is objected to 10) The drawing(s) filed on 23 Septimes Applicant may not request that an Replacement drawing sheet(s) income 11) The oath or declaration is object.	tember 2003 is/are: y objection to the draw duding the correction is	ving(s) be held in abeyance. Se s required if the drawing(s) is ob	e 37 CFR 1.85(a). ejected to. See 37 CFR 1.121(d).			
Priority under 35 U.S.C. § 119						
 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of: 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. 						
Attachment(s) 1) Notice of References Cited (PTO-892)		4) Intension Summeron	(PTO 413)			
 Notice of References Cited (PTO-892) Notice of Draftsperson's Patent Drawing Res Information Disclosure Statement(s) (PTO-1 Paper No(s)/Mail Date 2/19/04. 		4) Interview Summary Paper No(s)/Mail D 5) Notice of Informal I 6) Other:				

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DETAILED ACTION

PRIOR ART

1. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure.

U.S. Patent No. 6,774,448 to Lindemann et al. because it teaches a method of measuring the capacitance of integrated capacitors with overlap using thickness (d), free space permittivity (ε_0), relative permittivity (ε_r) of the passivation layer and the total overlap area (A) (see FIGS. 10 and 11 & column 7 line 34-44) as follows:

$$C = \frac{\varepsilon_o \varepsilon_r A}{d}$$

However, Lindemann et al. fails to discloses estimating the capacitance by adding the equation above with a second term $C_1 \cdot 2(W+L)$ with:

$$C_1 = \frac{\varepsilon_o}{\pi} \cdot K \cdot Ln(a)$$

 ϵ_{o} is the dielectric permittivity of free space,

$$K = \frac{\varepsilon_{ox} \cdot \varepsilon_{E}}{\varepsilon_{ox} - \left(\frac{\left(\varepsilon_{E} - \varepsilon_{ox}\right)^{2}}{\left(\varepsilon_{E} + \varepsilon_{ox}\right)} \cdot \frac{t_{oxSt}}{t_{ox}}\right)}$$

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$$a = -1 + 2k^2 + 2k\sqrt{k^2 - 1}$$
 with $k = 1 + \frac{t_{M1}}{t_{ox}}$

Allowable Subject Matter

- 2. Claims 1-16 allowed.
- 3. The following is an examiner's statement of reasons for allowance:

The primary reason for the allowance of claims 1-16 is the inclusion of the method step of estimating a capacitance by adding the equation

$$C = \frac{\varepsilon_o \varepsilon_r A}{d}$$
 with a second term $C_1 \cdot 2(W+L)$ with:

$$C_1 = \frac{\varepsilon_o}{\pi} \cdot K \cdot Ln(a)$$

 ε_o is the dielectric permittivity of free space,

$$K = \frac{\varepsilon_{ox} \cdot \varepsilon_{E}}{\varepsilon_{ox} - \left(\frac{\left(\varepsilon_{E} - \varepsilon_{ox}\right)^{2}}{\left(\varepsilon_{E} + \varepsilon_{ox}\right)} \cdot \frac{t_{oxSt}}{t_{ox}}\right)}$$

 $a = -1 + 2k^2 + 2k\sqrt{k^2 - 1}$ with $k = 1 + \frac{t_{M1}}{t_{ox}}$. It is this step found in each of the claims, as it is

claimed in the combination, that has not been found, taught or suggested by the prior art of record which makes these claims allowable over the prior art.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue

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fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for

Allowance."

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Anthony T. Dougherty whose telephone number is (571) 272-

2273. The examiner can normally be reached on Monday through Friday from 8 to 5.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, John E. Barlow can be reached on (571) 272-2269. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

atd

John Baryow
Supervisory Patent Examiner
Technology Center 2800